

Dual N-Channel MOSFET

General Description

The WSP11N10D is the highest performance trench Dual N-Channel MOSFET with extreme high cell density, which provide excellent $R_{DS(ON)}$ and gate charge for most of the synchronous buck converter applications.

The WSP11N10D meet the RoHS and Green Product requirement, $100\% E_{AS}$ guaranteed with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent Cdv/dt effect decline
- Green Device Available

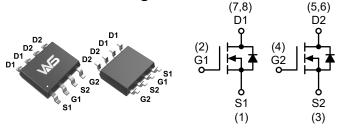
Product Summery

BV _{DSS}	R _{DS(ON)}	I _D
100V	65mΩ	11A

Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

SOP-8L Pin Configuration



Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	100	V
V _{GS}	Gate-Source Voltage	±20	V
I _D @T _C =25℃	Continuous Drain Current, V _{GS} @ 10V ¹	11	А
I _D @T _C =100℃	Continuous Drain Current, V _{GS} @ 10V ¹	5.5	А
I _{DM}	Pulsed Drain Current ²	33	А
EAS	Single Pulse Avalanche Energy ³	6.25	mJ
I _{AS}	Avalanche Current	5	А
P _D @T _A =25℃	Total Power Dissipation ⁴	23	W
T _{STG}	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range -55 to 150		°C

Thermal Data

Symbol	Parameter		Max.	Unit
R _{θJA}	Thermal Resistance Junction-ambient ¹		85	°C/W
R _{eJC}	Thermal Resistance Junction-Case ¹		3.02	°C/W



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Electrical Characteristics (T_J=25°C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} =0V , I _D =250uA	100			V	
$\triangle BV_{DSS} / \triangle T_J$	BV _{DSS} Temperature Coefficient	Reference to $25^\circ\!\mathbb{C}$, I_D=1mA		0.098		V/℃	
Б	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =5A	65 75				
R _{DS(ON)}		V _{GS} =4.5V , I _D =3A		80	95	mΩ	
V _{GS(th)}	Gate Threshold Voltage		1.2	1.8	2.5	V	
$ riangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	$V_{\rm GS} - V_{\rm DS}$, $I_{\rm D} - 2500$ A		-5.52		mV/℃	
	Drain Source Lookage Current	V_{DS} =100V , V_{GS} =0V , T_{J} =25 $^{\circ}$ C		1			
I _{DSS}	Drain-Source Leakage Current	V_{DS} =100V , V_{GS} =0V , T_{J} =55 $^{\circ}$ C			100	uA	
I _{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm20V$, $V_{DS}=0V$			±100	nA	
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		6.4		Ω	
Qg	Total Gate Charge (10V)			5.6			
Q _{gs}	Gate-Source Charge	V_{DS} =50V , V_{GS} =10V , I_{D} =10A		1.3		nC	
Q _{gd}	Gate-Drain Charge			1.2			
T _{d(on)}	Turn-On Delay Time			8			
Tr	Rise Time	V_{DD} =50V , V_{GEN} =10V ,		16			
T _{d(off)}	Turn-Off Delay Time	R _G =6Ω I _D =1A ,R∟=30Ω		17		ns	
T _f	Fall Time			14			
Ciss	Input Capacitance			204			
C _{oss}	Output Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		62		pF	
Crss	Reverse Transfer Capacitance			1.7			

Guaranteed Avalanche Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
EAS	Single Pulse Avalanche Energy ⁵	V _{DD} =50V , L=0.5mH , I _{AS} =5A	6			mJ

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,6}				11	А
I _{SM}	Pulsed Source Current ^{2,6}	V _G =V _D =0V , Force Current			30	А
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =5A , T _J =25℃			1.2	V
trr	Reverse Recovery Time			25		nS
Q _{rr}	Reverse Recovery Charge	IF=5A , dl/dt=100A/μs , T J=25℃		29		nC

Note :

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper,t<10sec.

2.The data tested by pulsed , pulse width $\leq 300 us$, duty cycle $\leq 2\%$

3. The EAS data shows Max. rating . The test condition is V_{DD} =50V, V_{GS} =10V, L=0.5mH, I_{AS} =5A

4.The power dissipation is limited by 150 $^\circ\!\mathrm{C}$ junction temperature

5.The Min. value is 100% EAS tested guarantee.

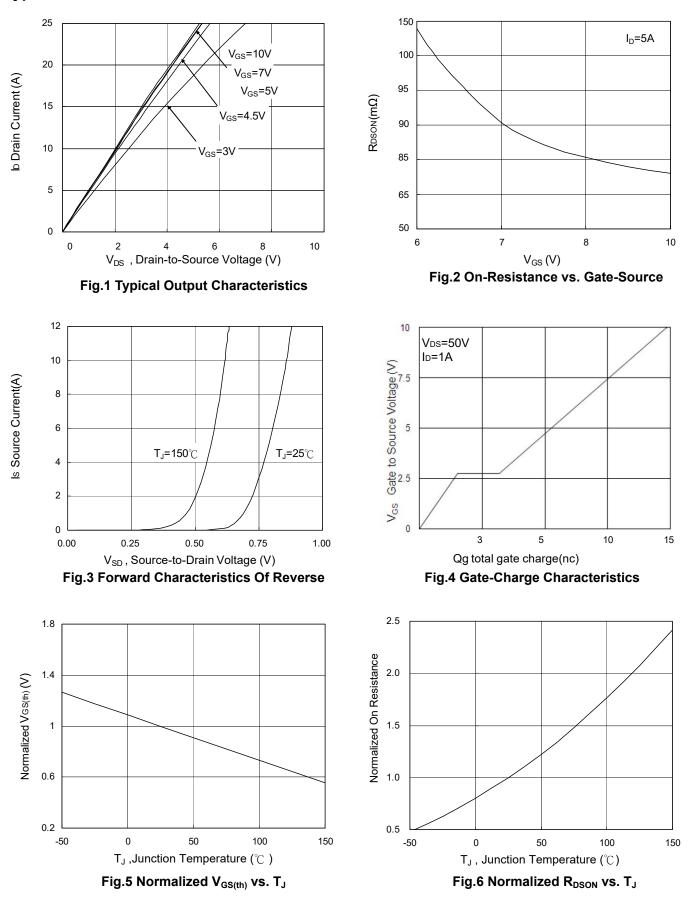
6. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



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Typical Characteristics





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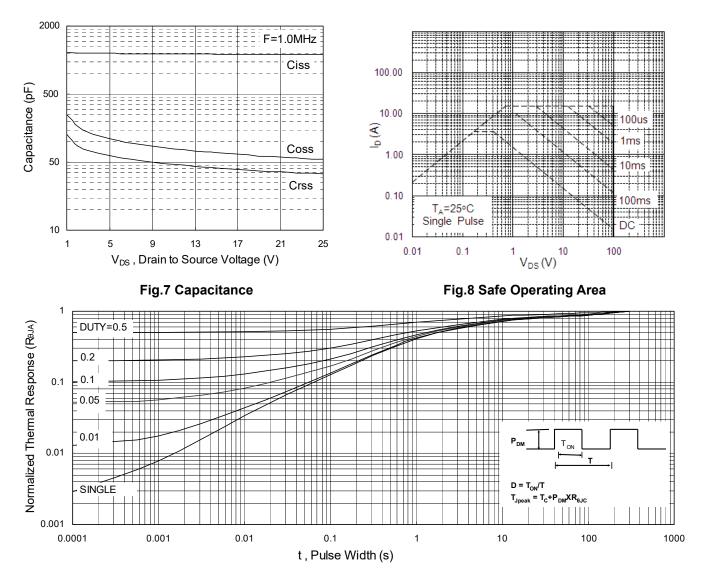


Fig.9 Normalized Maximum Transient Thermal Impedance

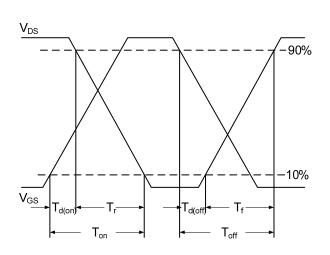


Fig.10 Switching Time Waveform

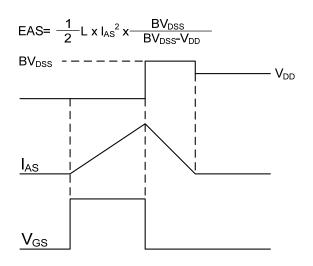


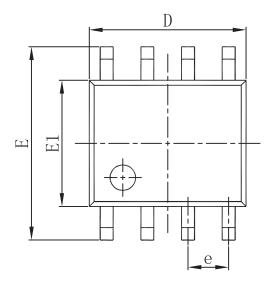
Fig.11 Unclamped Inductive Switching Waveform

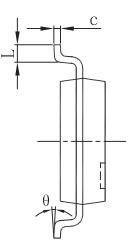


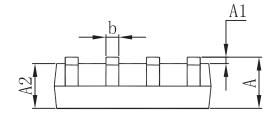


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Packaging information







Symbol	Dimensions In Millimeters		Dimensions In Inches		
	Min	Max	Min	Max	
А	1.350	1.750	0.053	0.069	
A1	0.100	0.250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
с	0.170	0.250	0.007	0.010	
D	4.800	5.000	0.189	0. 197	
e	1.270 (BSC)		0.050 ((BSC)	
Е	5.800	6.200	0. 228	0.244	
E1	3.800	4.000	0.150	0.157	
L	0.400	1.270	0.016	0.050	
θ	0°	8°	0°	8°	



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